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With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



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VOLTAGE DETECTOR

■ GENERAL DESCRIPTION

The NJU7700/01 is a high precision and low quiescent current voltage detector.

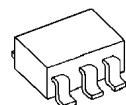
The detection voltage is internally fixed with an accuracy of 1.0%.

The NJU7700/01 are useful for preventing malfunction of microcomputer or DSP etc. through detect a drop in voltage of battery or power supply.

NJU7700 is Nch. Open Drain and NJU7701 is a C-MOS output type.

Small packaging makes NJU7700 and NJU7701 suitable for space conscious applications.

■ PACKAGE OUTLINE



NJU7700/01F

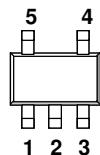


NJU7700/01F4

■ FEATURES

- High Precision Detection Voltage $\pm 1.0\%$
- Low Quiescent Current $0.8\mu A$ typ. ($V_{DET} = 3V$ version)
- Detection Voltage Range 1.3~6.0V(0.1V Step)
- Output Configuration NJU7700: Nch. Open Drain type
 NJU7701: C-MOS Output type
- CMOS Technology
- Package Outline SOT-23-5 : NJU7700/01F
 SC-82AB : NJU7700/01F4

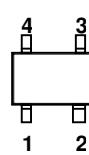
■ PIN CONFIGURATION



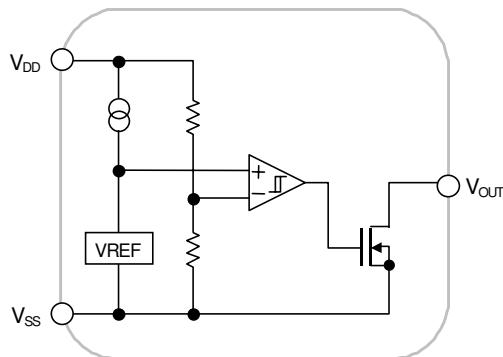
NJU7700/01F



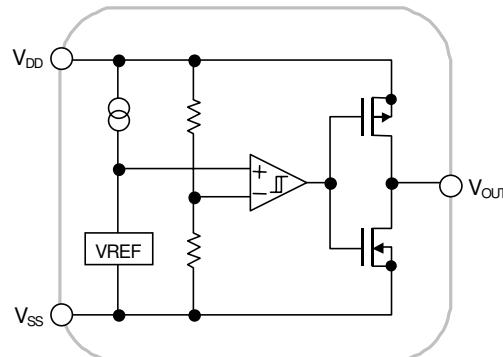
NJU7700/01F4



■ EQUIVALENT CIRCUIT



NJU7700



NJU7701

NJU7700/01

■ DETECTION VOLTAGE RANK LIST

Device Name	V_{DET}						
NJU770*F4-/F13	1.3V	NJU770*F4-/F23	2.3V	NJU770*F4-/F32	3.2V	NJU770*F4-/F43	4.3V
NJU770*F4-/F15	1.5V	NJU770*F4-/F24	2.4V	NJU770*F4-/F33	3.3V	NJU770*F4-/F44	4.4V
NJU770*F4-/F16	1.6V	NJU770*F4-/F25	2.5V	NJU770*F4-/F34	3.4V	NJU770*F4-/F45	4.5V
NJU770*F4-/F17	1.7V	NJU770*F4-/F26	2.6V	NJU770*F4-/F35	3.5V	NJU770*F4-/F47	4.7V
NJU770*F4-/F18	1.8V	NJU770*F4-/F27	2.7V	NJU770*F4-/F36	3.6V	NJU770*F4-/F05	5.0V
NJU770*F4-/F19	1.9V	NJU770*F4-/F28	2.8V	NJU770*F4-/F38	3.8V	NJU770*F4-/F52	5.2V
NJU770*F4-/F02	2.0V	NJU770*F4-/F29	2.9V	NJU770*F4-/F39	3.9V	NJU770*F4-/F55	5.5V
NJU770*F4-/F21	2.1V	NJU770*F4-/F03	3.0V	NJU770*F4-/F04	4.0V	NJU770*F4-/F06	6.0V
NJU770*F4-/F22	2.2V	NJU770*F4-/F31	3.1V	NJU770*F4-/F42	4.2V		

■ NJU7700

■ ABSOLUTE MAXIMUM RATINGS

(Ta=25°C)

PARAMETER	SYMBOL	RATINGS		UNIT
Input Voltage	V_{DD}	+10		V
Output Voltage	V_{OUT}	$V_{SS}-0.3 \sim +10$		V
Output Current	I_{OUT}	50		mA
Power Dissipation	P_D	F : SOT-23-5	200(*1)	mW
		F4 : SC-82AB	250(*2)	
Operating Temperature	T_{OPR}	-40 ~ +85		°C
Storage Temperature	T_{STG}	-40 ~ +125		°C

(*1) : Device itself

(*2) : Mounted on glass epoxy board based on EIA/JEDEC. (114.3x76.2x1.6mm: 2Layers)

■ ELECTRICAL CHARACTERISTICS

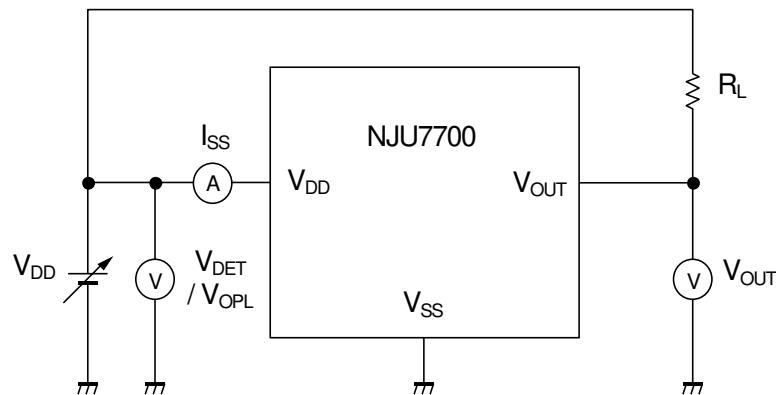
(Ta=25°C)

PARAMETER	SYMBOL	TEST CONDITION		MIN.	TYP.	MAX.	UNIT
Detection Voltage	V_{DET}			-1.0%	-	+1.0%	V
Hysteresis Voltage	V_{HYS}			$V_{DET} \times 0.03$	$V_{DET} \times 0.05$	$V_{DET} \times 0.08$	V
Quiescent Current	I_{SS}	$V_{DD}=V_{DET}+1V$	$V_{DET}=1.3V \sim 1.7V$ Version	-	0.5	1.0	μA
			$V_{DET}=1.8V \sim 6.0V$ Version	-	0.8	1.6	μA
Output Current	I_{OUT}	$Nch, V_{DS}=0.5V$	$V_{DD}=1.2V$	0.75	2.0	-	mA
			$V_{DD}=2.4V (\geq 2.7V$ Version)	4.5	7.0	-	mA
Output Leak Current	I_{LEAK}	$V_{DD}=V_{OUT}=9V$		-	-	0.1	μA
Detection Voltage Temperature Coefficient	$\Delta V_{DET} / \Delta T_a$	$T_a=0 \sim +85^{\circ}C$		-	±100	-	ppm/ $^{\circ}C$
Operating Voltage(*3)	V_{DD}	$R_L=100k\Omega$		0.8	-	9	V

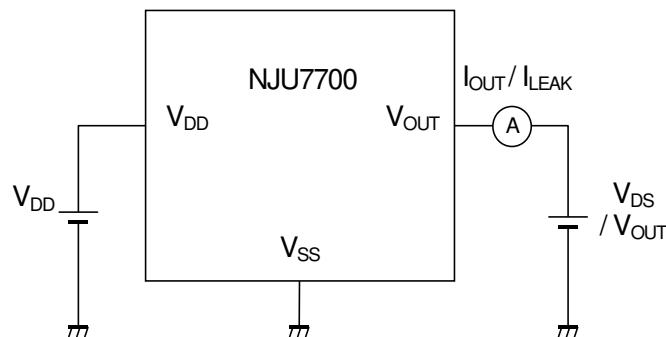
(*3): The minimum Operating Voltage(V_{OPL}) indicates the same value of the input voltage(V_{DD}) on condition that V_{OUT} becomes 10% or less of the input voltage(V_{DD}).

■ TEST CIRCUIT

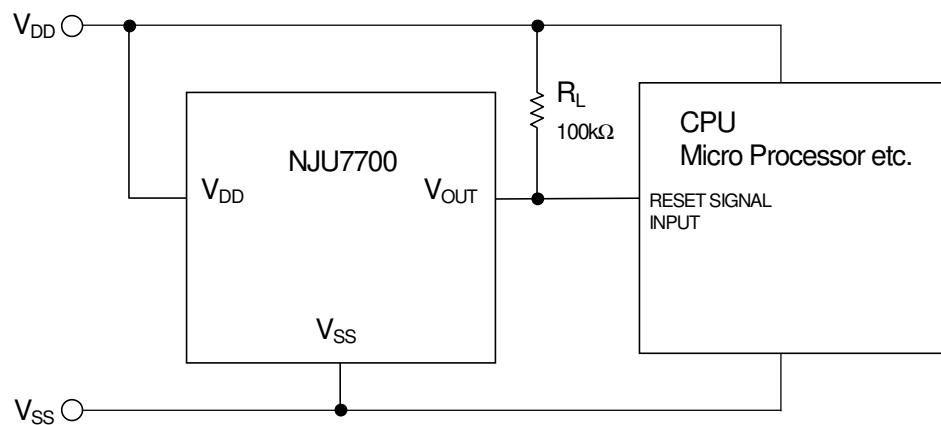
① COMMON TEST CIRCUIT



② OUTPUT CURRENT/OUTPUT LEAK CURRENT TEST CIRCUIT



■ TYPICAL APPLICATION



NJU7700/01

■ NJU7701

■ ABSOLUTE MAXIMUM RATINGS

(Ta=25°C)

PARAMETER	SYMBOL	RATINGS		UNIT
Input Voltage	V _{DD}	+10		V
Output Voltage	V _{OUT}	V _{SS} -0.3 ~ V _{DD} +0.3		V
Output Current	I _{OUT}	50		mA
Power Dissipation	P _D	F : SOT-23-5	200(*4)	mW
		F4 : SC-82AB	250(*5)	
Operating Temperature	To _{pr}	-40 ~ +85		°C
Storage Temperature	T _{STG}	-40 ~ +125		°C

(*4) : Device itself

(*5) : Mounted on glass epoxy board based on EIA/JEDEC. (114.3x76.2x1.6mm: 2Layers)

■ ELECTRICAL CHARACTERISTICS

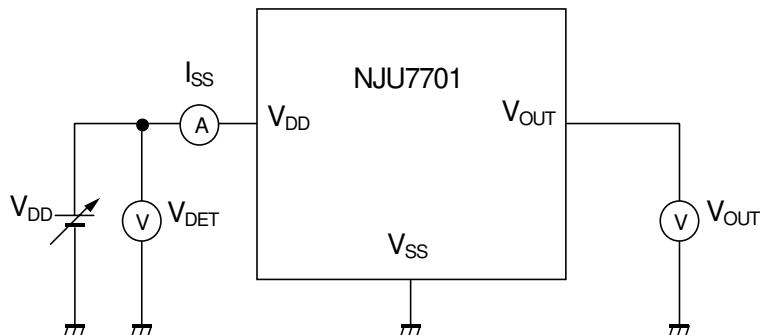
(Ta=25°C)

PARAMETER	SYMBOL	TEST CONDITION		MIN.	TYP.	MAX.	UNIT
Detection Voltage	V _{DET}			-1.0%	—	+1.0%	V
Hysteresis Voltage	V _{HYS}			V _{DET} ×0.03	V _{DET} ×0.05	V _{DET} ×0.08	V
Quiescent Current	I _{SS}	V _{DD} =V _{DET} +1V	V _{DET} =1.3V~1.7V Version	—	0.5	1.0	μA
			V _{DET} =1.8V~6.0V Version	—	0.8	1.6	μA
Output Current	I _{OUT}	Nch, V _{DS} =0.5V	V _{DD} =1.2V	0.75	2.0	—	mA
			V _{DD} =2.4V (\geq 2.7V Version)	4.5	7.0	—	mA
		Pch, V _{DS} =0.5V	V _{DD} =4.8V (\leq 3.9V Version)	2.0	3.5	—	mA
			V _{DD} =6.0V (4.0V~5.6V Version)	2.5	4.0	—	mA
Detection Voltage Temperature Coefficient	$\Delta V_{DET} / \Delta T_a$	Ta=0 ~ +85°C		—	±100	—	ppm/°C
		R _L =100kΩ		0.8	—	9	V

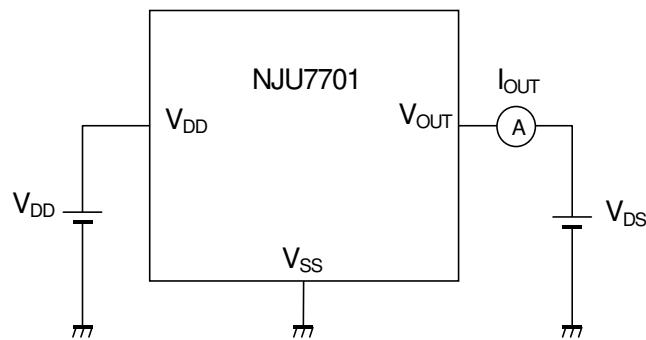
(*6): The minimum Operating Voltage(V_{OPL}) indicates the same value of the input voltage(V_{DD}) on condition that V_{OUT} becomes 10% or less of the input voltage(V_{DD}).

■ TEST CIRCUIT

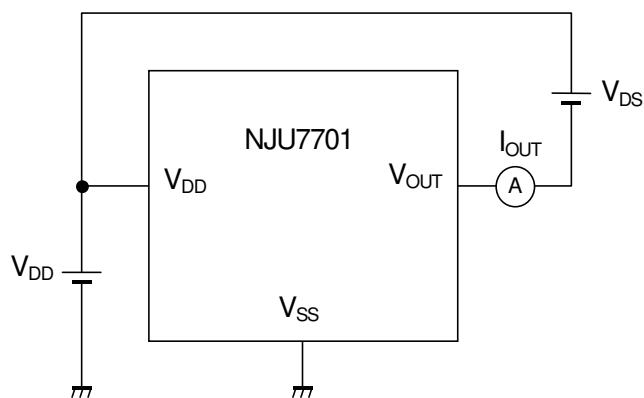
① COMMON TEST CIRCUIT



② Nch OUTPUT CURRENT TEST CIRCUIT

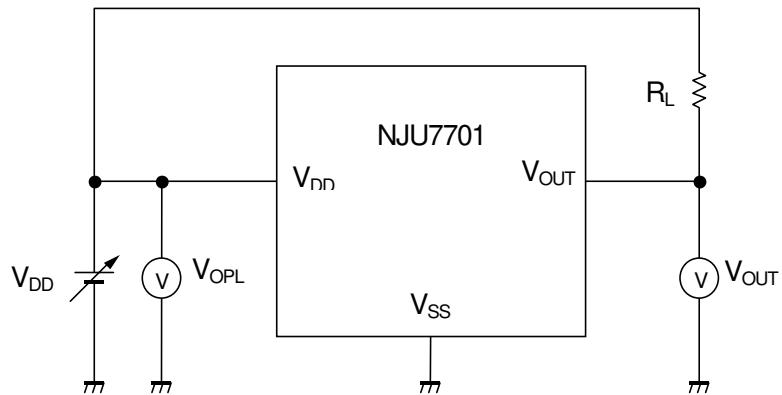


③ Pch OUTPUT CURRENT TEST CIRCUIT

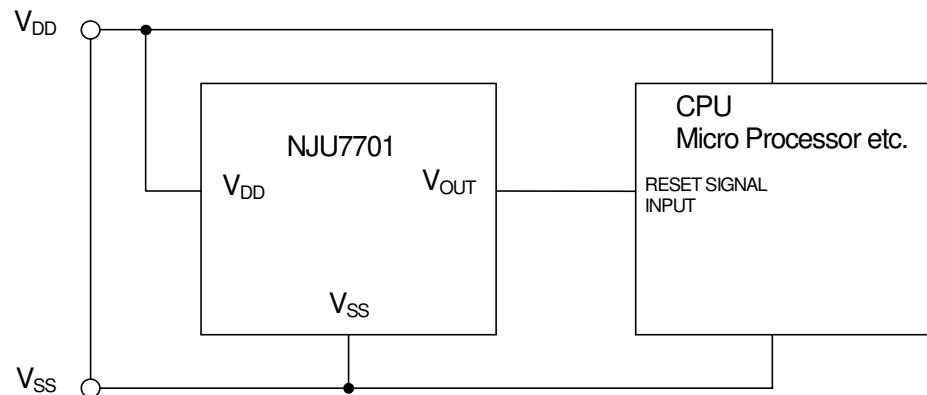


NJU7700/01

④ MINIMUM OPERATING VOLTAGE TEST CIRCUIT

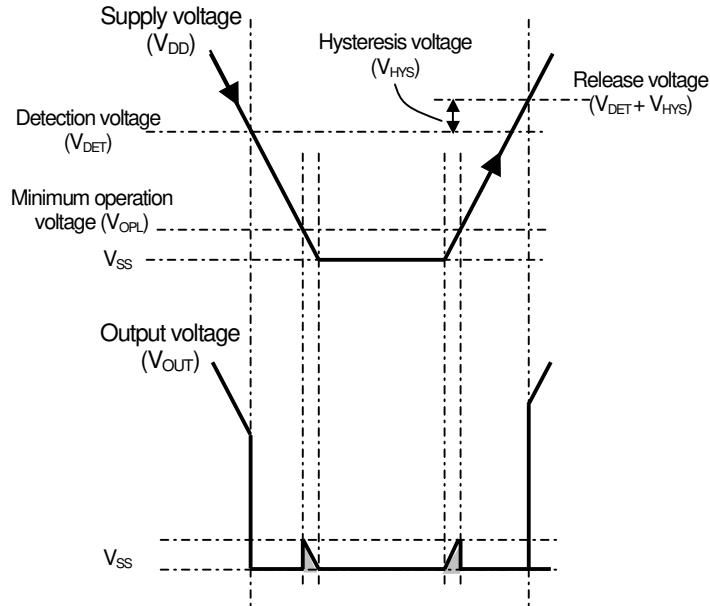


■ TYPICAL APPLICATION



■ FUNCTIONAL DESCRIPTION

(1) Basic operation



- (1) When supply voltage(V_{DD}) drops below detection voltage(V_{DET}), Output voltage(V_{OUT}) changes "H" to "L" to alert reset state.
- (2) The reset state is kept while V_{DD} is lower than release voltage. The release voltage is a sum of V_{DET} and Hysteresis voltage (V_{HYS}). Please refer to the (*7) below.
- (3) When V_{DD} becomes higher than the release voltage, then V_{OUT} changes from "L" to "H" to resume normal state.

(*7) V_{HYS} is to avoid unstable V_{OUT} state caused by rapid voltage change at nearby V_{DET} .

(*8): C-MOS output product (NJU7701) : When V_{DD} less than V_{OPL} , V_{OUT} is free of the shaded region.

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